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- 1) Nemamcha, M., Rouaiguia, S., Belbah, A., Belfarhi, B.
[Dielectric properties of alumino-silicate ceramic material](#)
(1995) IEEE International Conference on Conduction & Breakdown in Solid Dielectrics, pp. 413-417. Cited 1 time.
- 1) <https://www.scopus.com/inward/record.uri?eid=2-s2.0-0029543304&partnerID=40&md5=affaa0ac0fac3d43d0a613fed5365ae>
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- 2) Boufelfel, A., Falco, C.M.
[Thickness variation effects on X-ray scattering of multilayers](#)
(1995) Thin Solid Films, 258 (1-2), pp. 26-33. Cited 1 time.
- 2) <https://www.scopus.com/inward/record.uri?eid=2-s2.0-11744339141&doi=10.1016%2f0040-6090%2894%2906382-6&partnerID>
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